

# IRF420, IRF421, IRF422, IRF423

2.2A and 2.5A, 450V and 500V, 3.0 and 4.0 Ohm,  
N-Channel Power MOSFETs

## Features

- 2.2A and 2.5A, 450V and 500V
- $r_{DS(ON)} = 3.0\Omega$  and  $4.0\Omega$
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Majority Carrier Device
- Related Literature

## Description

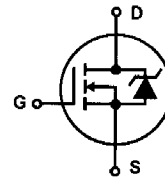
These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

## Ordering Information

PART NUMBER	PACKAGE	BRAND
IRF420	TO-204AA	IRF420
IRF421	TO-204AA	IRF421
IRF422	TO-204AA	IRF422
IRF423	TO-204AA	IRF423

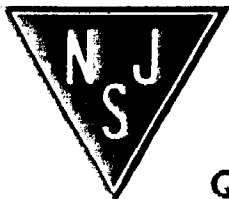
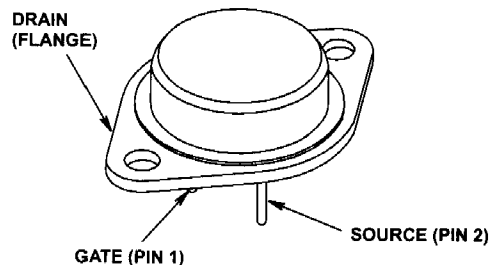
NOTE: When ordering, use the entire part number.

## Symbol



## Packaging

JEDEC TO-204AA



NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

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## IRF420, IRF421, IRF422, IRF423

### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ Unless Otherwise Specified

	IRF420	IRF421	IRF422	IRF423	UNITS
Drain to Source Breakdown Voltage (Note 1) . . . . . $V_{DS}$	500	450	500	450	V
Drain to Gate Voltage ( $R_{GS} = 20k\Omega$ ) (Note 1) . . . . . $V_{DGR}$	500	450	500	450	V
Continuous Drain Current . . . . . $I_D$	2.5	2.5	2.2	2.2	A
$T_C = 100^\circ\text{C}$ . . . . . $I_D$	1.6	1.6	1.4	1.4	A
Pulsed Drain Current (Note 3) . . . . . $I_{DM}$	10	10	8	8	A
Gate to Source Voltage . . . . . $V_{GS}$	$\pm 20$	$\pm 20$	$\pm 20$	$\pm 20$	V
Maximum Power Dissipation . . . . . $P_D$	50	50	50	50	W
Linear Derating Factor . . . . .	0.4	0.4	0.4	0.4	W/ $^\circ\text{C}$
Single Pulse Avalanche Energy Rating (Note 4) . . . . . $E_{AS}$	210	210	210	210	mJ
Operating and Storage Temperature . . . . . $T_J, T_{STG}$	-55 to 150	-55 to 150	-55 to 150	-55 to 150	$^\circ\text{C}$
Maximum Temperature for Soldering					
Leads at 0.063in (1.6mm) from Case for 10s . . . . . $T_L$	300	300	300	300	$^\circ\text{C}$
Package Body for 10s, See TB334 . . . . . $T_{pkg}$	260	260	260	260	$^\circ\text{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

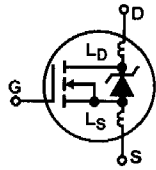
- $T_J = 25^\circ\text{C}$  to  $125^\circ\text{C}$ .

### Electrical Specifications $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified

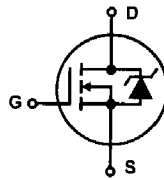
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage IRF420, IRF422	$BV_{DSS}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ , (Figure 10)	500	-	-	V
			IRF421, IRF423	450	-	-
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	2.0	-	4.0	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = \text{Rated } BV_{DSS}, V_{GS} = 0\text{V}$	-	-	25	$\mu\text{A}$
		$V_{DS} = 0.8 \times \text{Rated } BV_{DSS}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$	-	-	250	$\mu\text{A}$
On-State Drain Current (Note 2) IRF420, IRF421	$I_{D(ON)}$	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}, V_{GS} = 10\text{V}$ (Figure 7)	2.5	-	-	A
			IRF422, IRF423	2.2	-	-
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20\text{V}$	-	-	$\pm 100$	nA
Drain to Source On Resistance (Note 2) IRF420, IRF421	$r_{DS(ON)}$	$I_D = 1.4\text{A}, V_{GS} = 10\text{V}$ , (Figures 8, 9)	-	2.5	3.0	$\Omega$
			IRF422, IRF423	-	3.0	4.0
Forward Transconductance (Note 2)	$g_{fs}$	$V_{DS} \geq 10\text{V}, I_D = 2.0\text{A}$ , (Figure 12)	1.5	2.3	-	S
Turn-On Delay Time	$t_{d(ON)}$	$V_{DD} = 250\text{V}, I_D = 2.5\text{A}, R_G = 18\Omega, R_L = 96\Omega, V_{GS} = 10\text{V}$ , (Figures 17, 18) MOSFET Switching Times are Essentially Independent of Operating Temperature	-	10	15	ns
Rise Time	$t_r$		-	12	18	ns
Turn-Off Delay Time	$t_{d(OFF)}$		-	28	42	ns
Fall Time	$t_f$		-	12	18	ns
Total Gate Charge (Gate to Source + Gate to Drain)	$Q_g(\text{TOT})$		$V_{GS} = 10\text{V}, I_D = 2.5\text{A}, V_{DS} = 0.8 \times \text{Rated } BV_{DSS}, I_{G(\text{REF})} = 1.5\text{mA}$ , (Figures 14, 19, 20) Gate Charge is Essentially Independent of Operating Temperature	-	11	19
Gate to Source Charge	$Q_{gs}$		-	5	-	nC
Gate to Drain "Miller" Charge	$Q_{gd}$		-	6	-	nC

## IRF420, IRF421, IRF422, IRF423

### Electrical Specifications $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Input Capacitance	$C_{ISS}$	$V_{DS} = 25\text{V}$ , $V_{GS} = 0\text{V}$ , $f = 1\text{MHz}$ , (Figure 11)		-	300	-	pF
Output Capacitance	$C_{OSS}$			-	75	-	pF
Reverse Transfer Capacitance	$C_{RSS}$			-	20	-	pF
Internal Drain Inductance	$L_D$	Measured between the Contact Screw on the Flange that is Closer to Source and Gate Pins and the Center of Die.	Modified MOSFET Symbol Showing the Internal Devices Inductances. 	-	5.0	-	nH
Internal Source Inductance	$L_S$	Measured from the Source Lead, 6mm (0.25in) from the Flange and Source Bonding Pad.		-	12.5	-	nH
Thermal Resistance Junction to Case	$R_{\theta JC}$			-	-	2.5	$^\circ\text{C/W}$
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Free Air Operation		-	-	30	$^\circ\text{C/W}$

### Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	$I_{SD}$	Modified MOSFET Symbol Showing the Integral Reverse P-N Junction Diode 	-	-	2.5	A	
Pulse Source to Drain Current (Note 3)	$I_{SDM}$		-	-	10	A	
Source to Drain Diode Voltage (Note 2)	$V_{SD}$	$T_J = 25^\circ\text{C}$ , $I_{SD} = 2.5\text{A}$ , $V_{GS} = 0\text{V}$ , (Figure 13)		-	-	1.4	V
Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ\text{C}$ , $I_{SD} = 2.5\text{A}$ , $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		130	270	540	ns
Reverse Recovered Charge	$Q_{RR}$	$T_J = 25^\circ\text{C}$ , $I_{SD} = 2.5\text{A}$ , $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		0.57	1.2	2.3	$\mu\text{C}$

**NOTES:**

2. Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
3. Repetitive rating: pulse width limited by max junction temperature. See Transient Thermal Impedance curve (Figure 3).
4.  $V_{DD} = 50\text{V}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 60\text{mH}$ ,  $R_G = 25\Omega$ , peak  $I_{AS} = 2.5\text{A}$ , Figures 15, 16.